

Notice of References Cited

Application/Control No.

10/719,409

Applicant(s)/Patent Under
Reexamination
FURTEK ET AL.

Examiner

Scott Sun

Art Unit

2182

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0042875 A1	04-2002	Shukla, Jayant	713/151
*	B	US-2003/0074473 A1	04-2003	Pham et al.	709/246
*	C	US-6,675,284 B1	01-2004	Warren, Robert	712/38
*	D	US-6,980,515 B1	12-2005	Schunk et al.	370/230.1
*	E	US-2001/0052793	12-2001	Nakaya, Shogo	326/41
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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